XRD Training Notebook

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University of California, Riverside
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Before you begin...

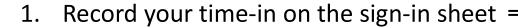
Complete the required safety training modules on UC Learning Laboratory Safety Orientation (Fundamentals) 2013 Hazardous Waste Management X-Ray Safety **Compressed Gas Safety** Submit a copy of your Training Transcript to Lab Manager Review the MSE XRD Policies and Regulations Fill out the XRD FAU Authorization Form with PI signature Receive a user name and temporary password for Faces scheduling Arrange a time for XRD training with Lab Manager Schedule a 2 hour block on Faces for your training Receive a Data Collector password

XRD Operation

| I. | Initiate Software | IX. | New Measurement Program |
|-----------|-------------------|-----|-------------------------|
| | | | |

- II. Sample Preparation X. Editing Measurement Program
- III. Membrane Holders XI. Start Measurement
- IV. Irregular Holders XII. Data Viewing and Exporting
- V. Round Holders XIII. Data Analysis
- VI. Sample Loading XIV. Sample Unloading
- VII. XRD Cabinet XV. Cleanup
- VIII. X-Ray Settings XVI. Troubleshoot

Initiate Software – 1/1





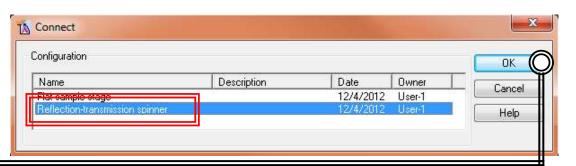
- 2. Log-in with your *ENGR* account at the *Windows Sign-In Prompt*
- Double left-click on the Data Collector icon =



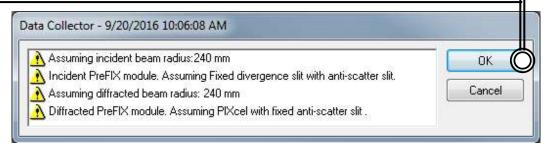
4. Select *Instrument -> Connect*



Select Reflection-Transmission
 Spinner and click OK ————



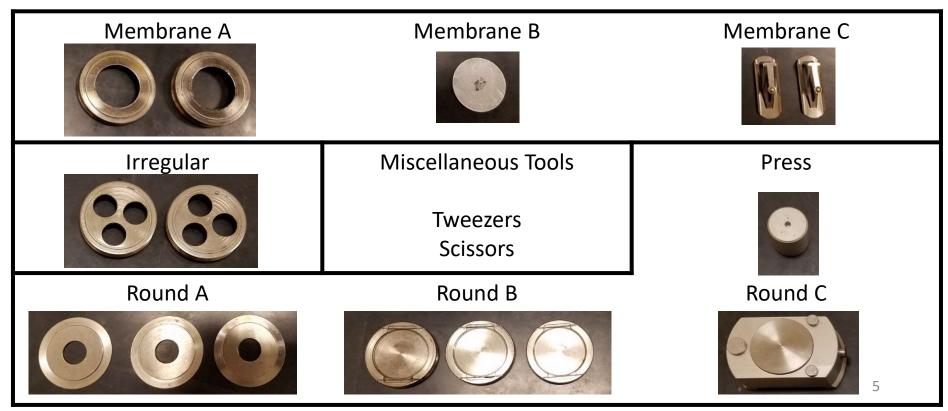
6. A dialogue box will appear, just click **OK**



II. Sample Preparation – 1/2

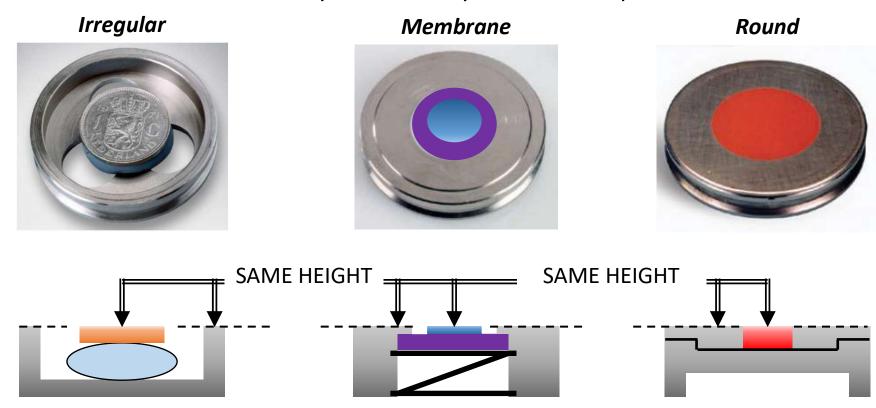
- 1. The sample holder and preparation will vary depending on your sample
- 2. Three types of sample holders are available for use are located in the storage container
- 3. CLEAN UP AFTER EACH USE AND WIPE DOWN!



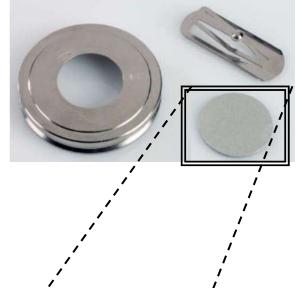


II. Sample Preparation – 2/2

- 4. It is important to always have the top of your sample at the SAME height as the top of your sample holder (no exception!)
- 5. If your sample is not at the same height as your sample holder, the peaks obtained will be incorrectly shifted away from correct positions!



III. Membrane Holders – 1/1



- 1. This holder is designed for mounting:
 - dust filters
 - sample mounting plates
 - metal plates
 - pressed pellets
 - silicon substrates
- 2. Requires a support plate (Diameter = 32 mm)
 - Aluminum support provided (will have background Al peaks)
 - Recommend Si Zero Background Plate
 - These need to be provided by users



MTI Corp: Zero Diffraction Plate 32 mm Dia. x 2.0 mm t, Si Crystal for XRD sample (\$150)



MTI Corp: Zero Diffraction Plate with Cavity for XRD sample: 32 Dia x 2.0 t mm with Cavity 10 ID x 0.2 mm, Si Crystal (\$199)

Warning: X-ray beam shall be 5 mm dia or less (<u>current installed beam mask is 10 mm</u>) and hit in the center of sample when you use cavity zero diffraction plate!

Otherwise the edge may result in a peak. USE AT YOUR OWN RISK!

IV. Irregular Holders – 1/1



- This holder can be used to analyze solid samples with:
 - Maximum diameter = 45 mm
 - Maximum thickness = 6.5 mm
- The sample can be mounted with clay available from Storehouse:



- Storehouse Description: <u>SARGENT ART 22-4096 1LB MODELING</u> CLAY, WHITE (Stock #: 48702-108)
- 3. Recommend using a glass slide or Si zero background plate as support for your sample on top of clay



MTI Corp: Zero Diffraction Plate 32 mm Dia. x 2.0 mm t, Si Crystal for XRD sample (\$150)



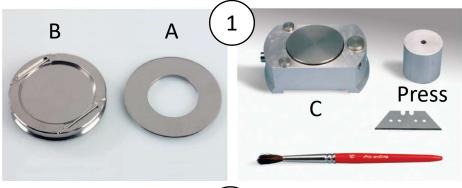
MTI Corp: Zero Diffraction Plate with Cavity for XRD sample: 32 Dia x 2.0 t mm with Cavity 10 ID x 0.2 mm, Si Crystal (\$199)

Warning: X-ray beam shall be 5 mm dia or less (<u>current installed beam mask is 10 mm</u>) and hit in the center of sample when you use cavity zero diffraction plate!

Otherwise the edge may result in a peak. USE AT YOUR OWN RISK!

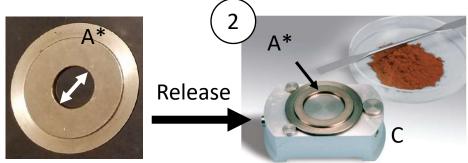
8

V. Round Holders – 1/2

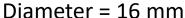


1. Assemble the items for powder samples (user provides razor and brush)

REMEMBER TO CLEAN ALL SURFACES FIRST BEFORE USING!



2. Invert A to get A*. Place on top of C and push the release to have it sit into place.

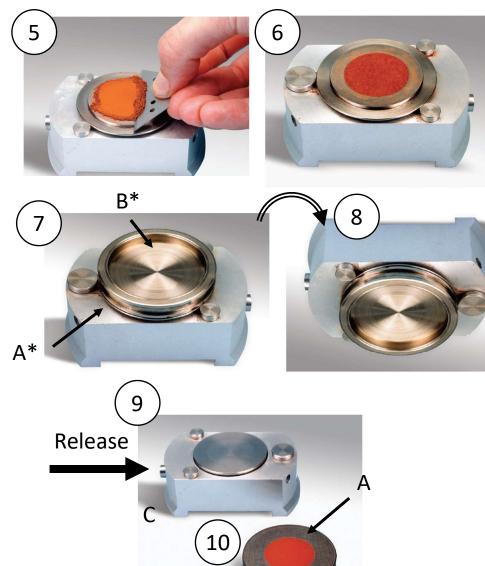






- 3. Spread the powder into the cavity using a spatula but do not pack or compress.
- 4. Press powder with Aluminum press

V. Round Holders – 2/2



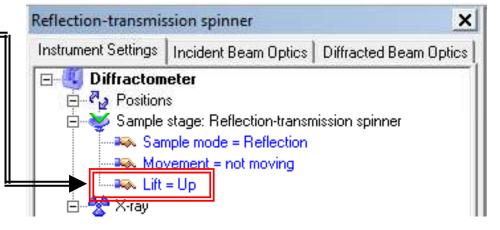
5. Remove excess powder with a straight edge or side of microscope slide

DO NOT SCRATCH TOP SURFACE!

- 6. Clean mating surfaces with small brush or provided kim wipe
- 7. Invert B to get B* and snap on top of A*
- 8. Flip entire assembly
- 9. Push the release to remove the sample holder (A + B) from C
- 10. The surface of your sample should be smooth via back-filling approach

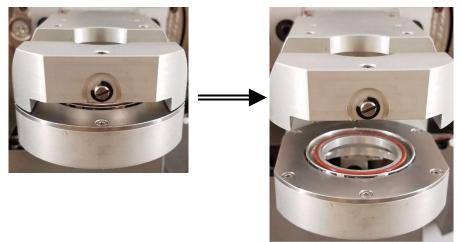
VI. Sample Loading – 1/4

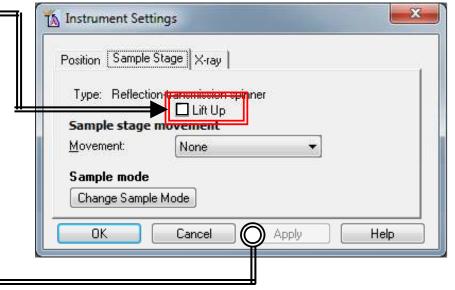
1. Double-click on "Lift = Up"



2. Uncheck the "Lift Up" option = and click Apply = ______

3. The stage will now drop down





VI. Sample Loading – 2/4

4. Press "UNLOCK DOORS" on cabinet

 Open doors by pulling on the handles at the ends for better leverage ———

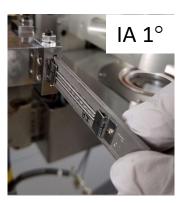


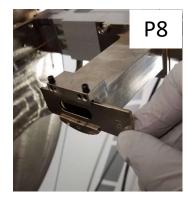


Inspect and check if desired slits are installed

- Standard Slits are default:
 - Inc Div ½°
 - Inc Ant 1°
 - Dif Ant P8



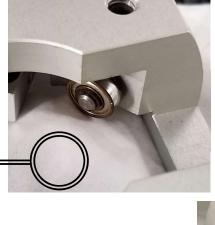


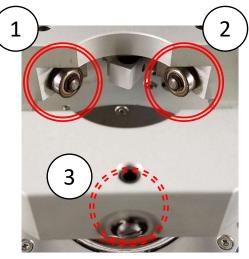


VI. Sample Loading – 3/4

7. Inspect *Stage* for any residual sample left stuck on **3** *Spinner Bearings* from previous user

- 8. Take *Kimwipe* with *IPA* and carefully wipe all *3 Spinner Bearings*
- 9. Use fresh area on *Kimwipe* to remove residual sample
- 10. Fold, and use fresh area of *Kimwipe* to wipe down the base of the *Stage*
- 11. If necessary, use provided *Air Duster* to dry and remove any remaining dust on *Stage*









VI. Sample Loading – 4/4

12. Carefully insert *Sample Holder* into *Stage*







The Instrument Settings

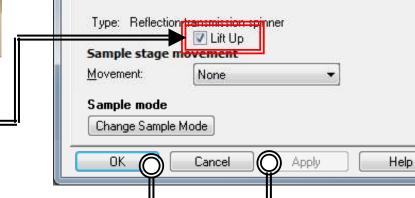
Position Sample Stage X-ray

13. Confirm *Sample Holder* is properly seated into *Stage* =





15. Check the "Lift Up" option and click Apply

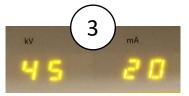


16. Click **OK** _____

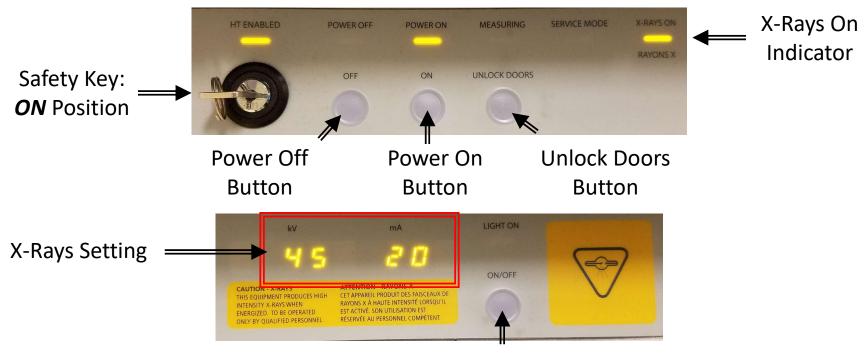
VII. XRD Cabinet – 1/5

- 1. Always remember to check 3 indicators that XRD is **OK**
 - White Power Light is On
 - X-Rays On Light is On
 - X-Ray settings are 45 kV and 20 mA

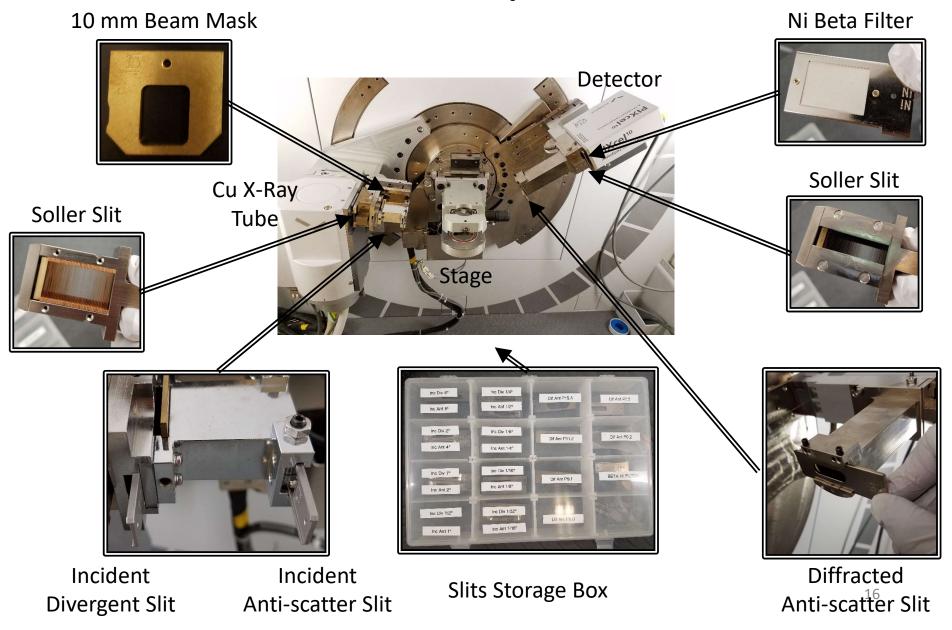




Note: If above 3 indicators are missing, contact Lab Manager

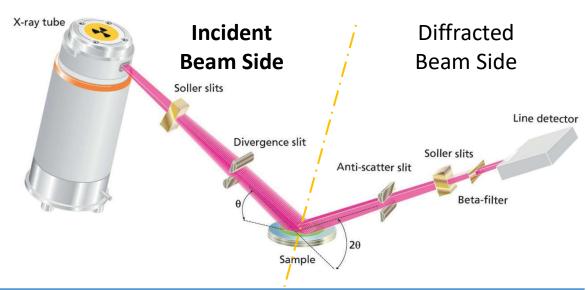


VII. XRD Cabinet – 2/5



VII. XRD Cabinet – 3/5

The following table describes the components for the **Incident Beam Side**

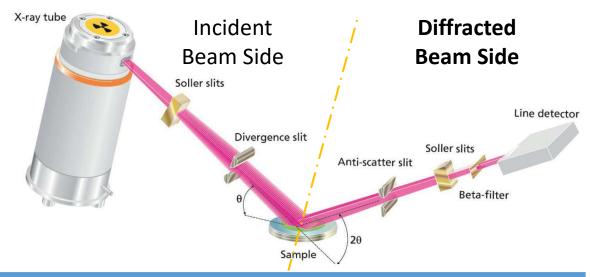


Incident Beam Side

| Component Name | Function or Description | | |
|-------------------------------|---|--|--|
| Soller Slit | Prevents axial divergence and improves peak shape and symmetry | | |
| Divergence Slit | Controls the irradiated length of the X-Ray beam on the sample. Slit size depends on sample size and starting scan angle. | | |
| Incident Anti-scatter Slit | Reduces X-Ray beam scatter and reduces background. Typically double the selection of the divergent slit. | | |
| Beam Mask (not pictured) | Controls axial width of the X-Ray beam. Match to sample size. 17 | | |

VII. XRD Cabinet – 4/5

The following table describes the components for the **Diffracted Beam**Side



Diffracted Beam Side

| Component Name | Function or Description | | |
|----------------------------------|--|--|--|
| Receiving Slit | Controls the resolution of the instrument, common setting is 0.1 mm. | | |
| Soller Slit | Match with incident selection, typically 0.04 radians. | | |
| Diffracted Anti- scatter Slit | Match to the selection of the Divergent Slit. | | |
| Beta-filter | Used to remove beta radiation. | | |
| Detector | PIXcel 1D 18 | | |

VII. XRD Cabinet – 5/5

Standard Slit Configuration = 1/2°, 1°, 8 mm

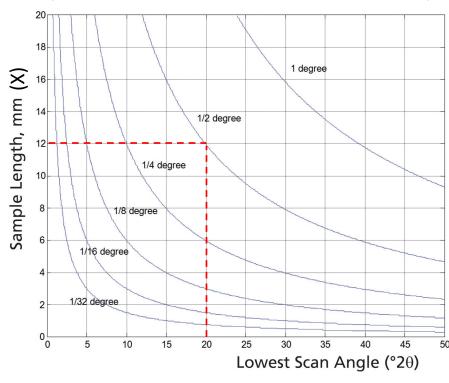
| Slit Configurations | | | | | |
|--------------------------------|--------------------------|---|--|--|--|
| Incident E | Incident Beam Side | | | | |
| Incident D ivergence | Incident Anti-scatter | D iffracted A nti-scatter | | | |
| ID 4° | IA 8° | P15.4 | | | |
| ID 2° | IA 4° | P11.2 | | | |
| ID 1° | IA 2° | P9.1 | | | |
| ID 1/2 ° | IA 1 ° | P8.0 | | | |
| ID 1/4° | IA 1/2° | P7.5 | | | |
| ID 1/8° | IA 1/4° | P7.5 | | | |

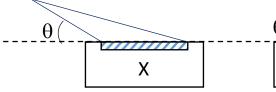
Decreasing Slit Size

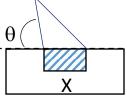
Choose smaller slit sizes for removing background intensity at low angles

Effects of Low Scan Angles: Irradiated Sample Length X vs. $^{\circ}2\theta$

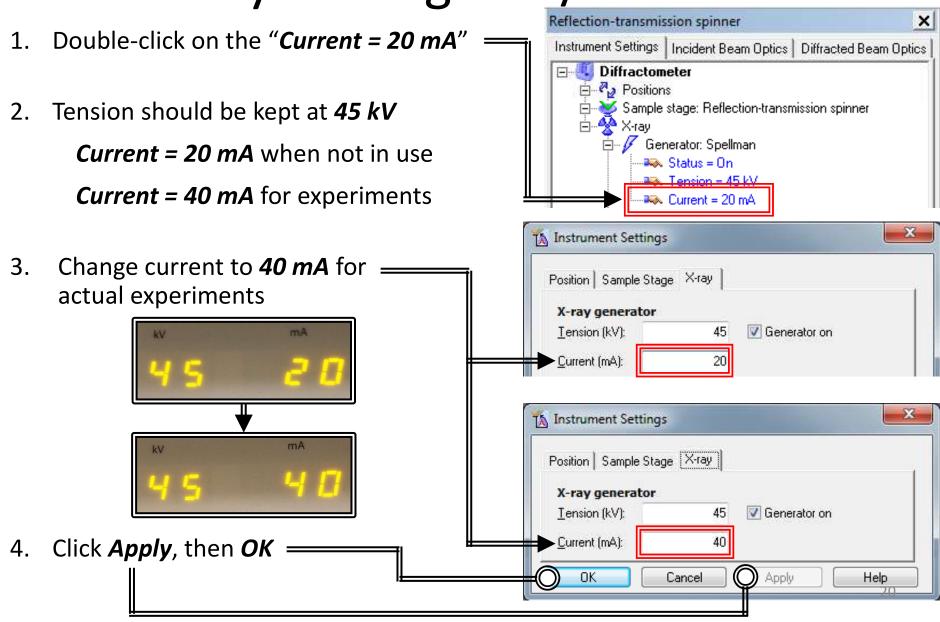
(Ex: $^{\circ}2\theta = 20^{\circ}$ with ID $\frac{1}{2}^{\circ} => X = 12$ mm)





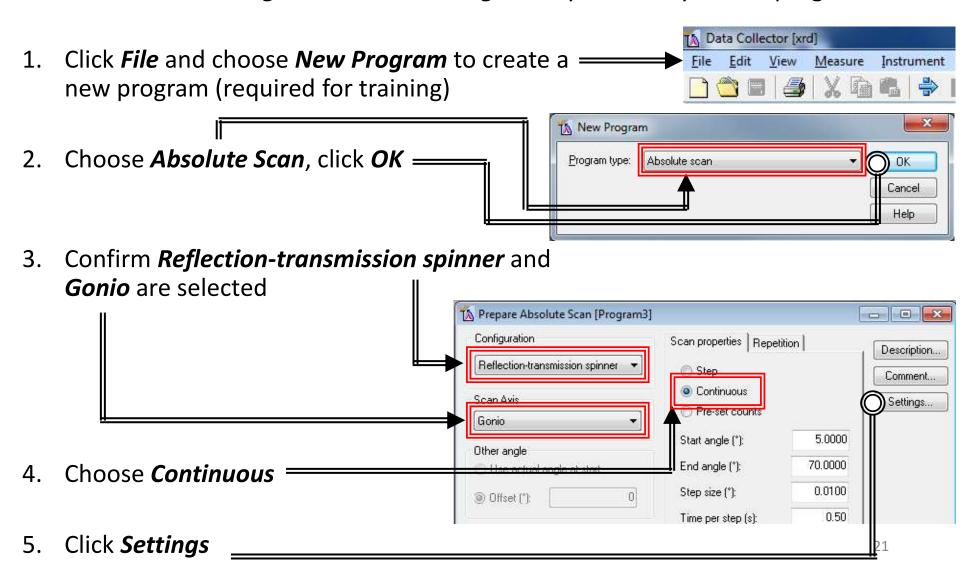


VIII. X-Ray Settings — 1/1



IX. New Measurement Program – 1/7

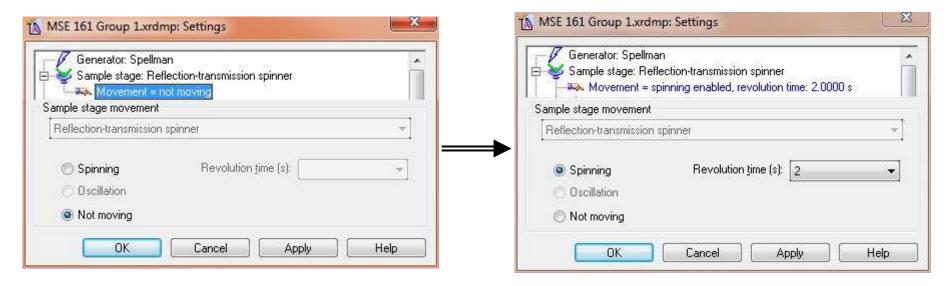
Note: **SKIP** to *X. Editing Measurement Program* if you already have a program



IX. New Measurement Program – 2/7

6. Click **Movement**

- Set to Spinning Enabled (recommended)
 - Set Revolution Time = 2 seconds
- Set to Not moving if homogeneity is not an issue but sample ejection is



7. The default settings show "Actual" (meaningless) for all entries

IX. New Measurement Program – 3/7

8. Set the following *Incident beam path* entries as follows: —

☐ PreFIX module: FDS with FASS (Fixed divergence slit with anti-scatter slit)

□ Soller slit: **Soller slits 0.04 rad**

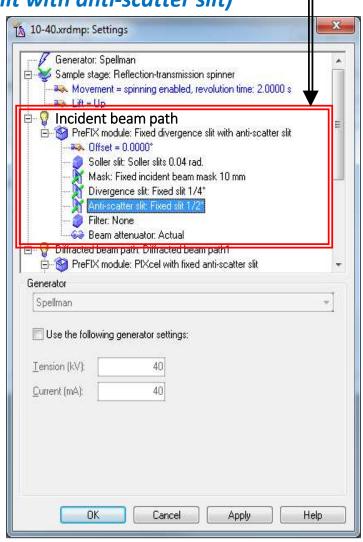
■ Mask: Fixed incident beam mask 10 mm

☐ Filter: *None*

Beam attenuator: None

☐ Divergence slit: <**Enter what you're using>**; if **Standard Slits** then **Fixed slit 1/2** °

Anti-scatter slit: **<Enter what you're using>**; if **Standard Slits** then **Fixed slit 1**°



IX. New Measurement Program – 4/7

Repeat for the **Diffracted beam path** entries as follows: =

□ PreFIX module: PIXcel with FASS (Fixed anti-scatter slit)

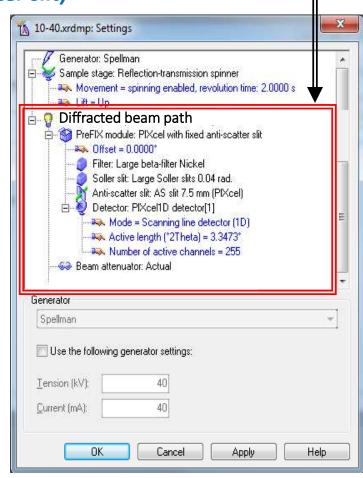
Filter: Large beta-filter Nickel

☐ Soller slit: *Large soller slits 0.04 rad*

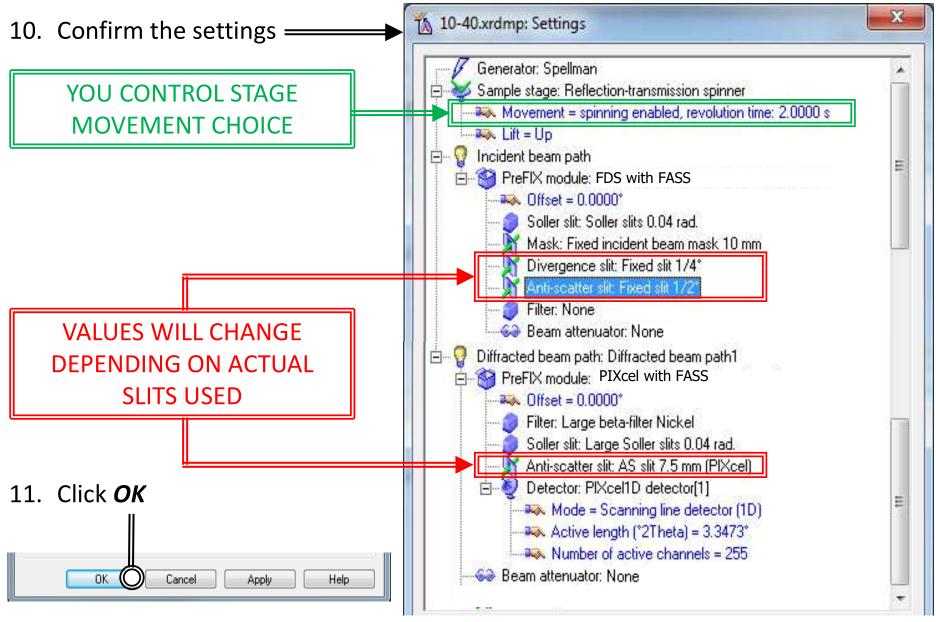
☐ Detector: **PIXcel1D detector[1]**

Beam attenuator: None

□ Anti-scatter slit: <<u>Enter what you're using</u>>;
if Standard Slits then AS slit 8.0mm (PIXcel)



IX. New Measurement Program – 5/7



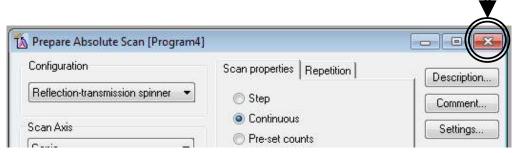
IX. New Measurement Program – 6/7

12. Click *Description* and *Comment* tabs to enter information if desired TA Comment Measurement Program Description Description: Cancel OK Cancel 13. Set *Start Angle*, (eg. **10**°) Scan properties | Repetition | Description... Step Comment... 14. Set *End Angle*, (eg. **80°**) Continuous Settings... Pre-set counts 10.0000 Start angle (*): 15. Set **Step Size**, (eg. **0.1**°) End angle (°): 80.0000 - decrease to enhance resolution 0.1000 Step size (*): Time per step (s): 30.00 16. Set *Time Per Step*, (eg. **30 sec**) Net time per step (s): - *increase* to enhance *signal/noise* Scan speed (*/s): 0.200000 Pre-set counts (counts): 100008 Number of steps: 700 17. The *Total Time* (h:m:s) for the scan = Total time (h:m:s): 0:01:26 will automatically update

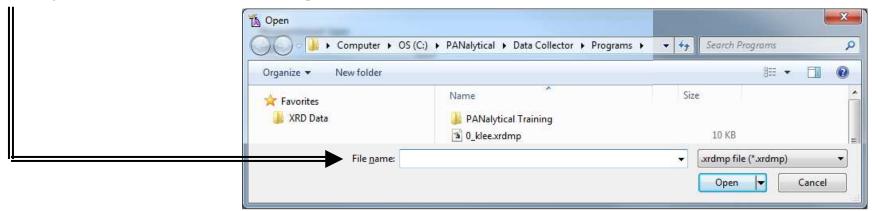
26

IX. New Measurement Program – 7/7

- 18. Click the *Close X* to close the window =
- 19. Choose to **SAVE** your program
- 20. Select your <**PI'S NAME**> folder



21. Name your *Measurement Program* file



- 22. Default unsorted folder is "C:\PANalytical\Data Collector\Programs"
- 23. Continue to XI. Start Measurement and SKIP X. Edit Measurement Program

X. Editing Measurement Program – 1/1

Edit View

Measure

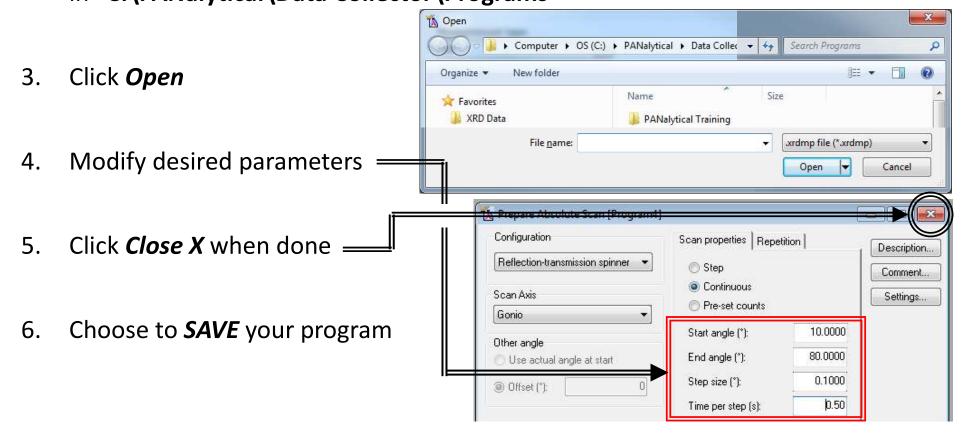
Instrument

The following steps are for **EDITING** existing program you already created only!

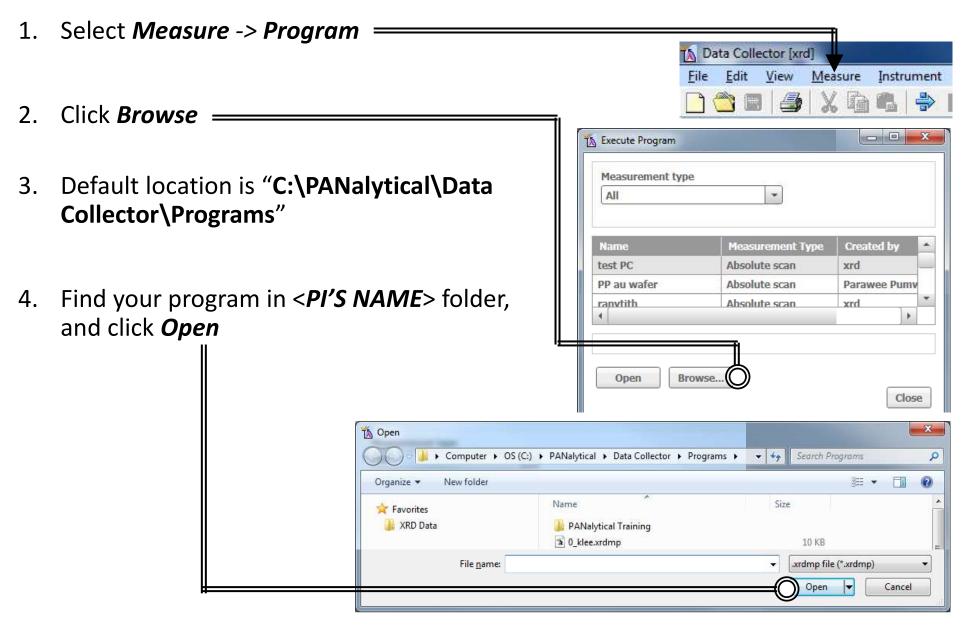
SKIP to **XI. Start Measurement** if you don't need to edit your program

TA Data Collector [xrd] Click File and choose Open Program

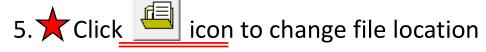
Click **Browse** and find program in <**PI'S NAME**> folder in "C:\PANalytical\Data Collector\Programs"



XI. Start Measurement – 1/3



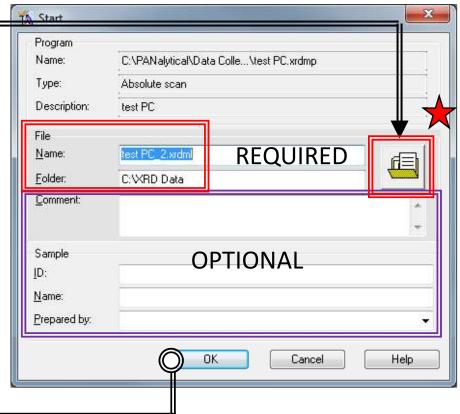
XI. Start Measurement – 2/3



- 6. Default is unsorted in "C:\XRD Data"
- 7. Select your <**PI'S NAME**> folder
- 8. Select your *Folder* for this scan
- 9. Enter a *Name* for your scan
- 10. Confirm correct *File Folder* location
- 11. Enter a Comment, Sample ID, Sample name, or Username if desired
- 12. Clicking **OK** will start your scan!

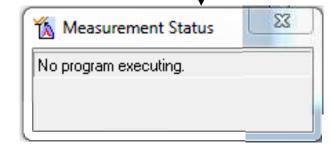


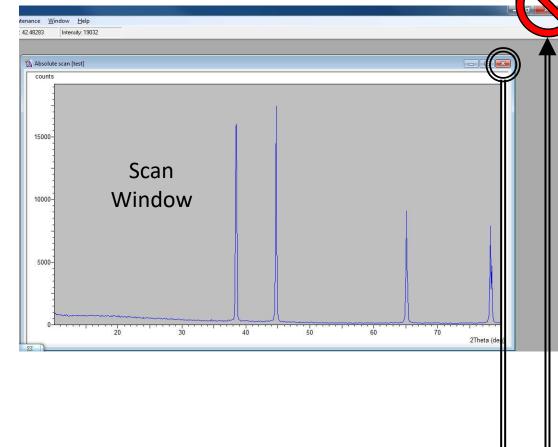
NOTE: THE MESSAGE SHOULD ONLY BE ABOUT CHECKING THAT THE COMBINATION OF SLITS YOU HAVE INDICATED IN YOUR PROGRAM ARE INSTALLED



XI. Start Measurement – 3/3

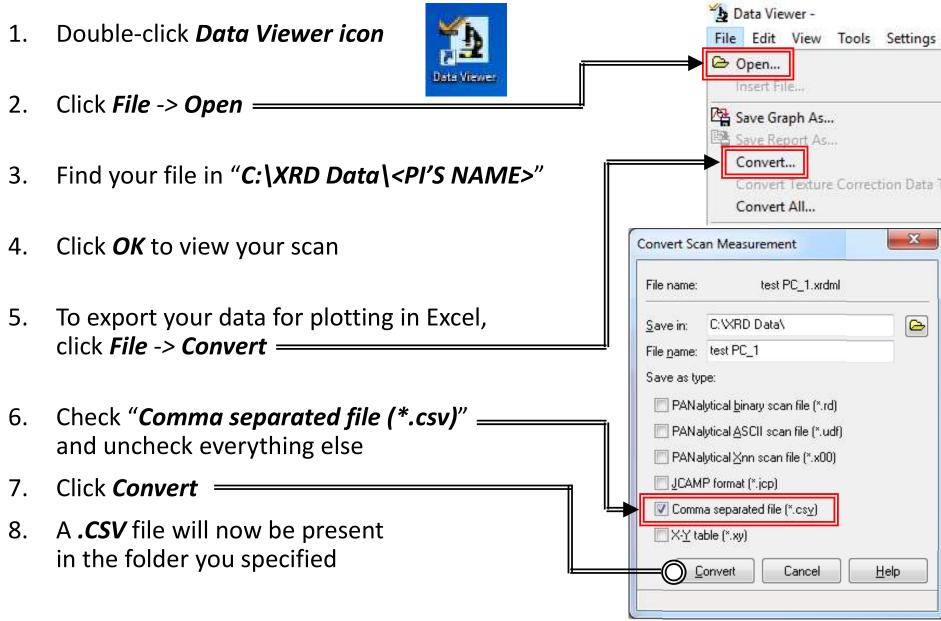
- 14. The scan will initiate
- 15. Scale changes as the measurement proceeds
- 16. Scan is complete when "No program executing" is shown





- 17. Once scan is complete, click the Close X to close the scan window =
- 18. DO NOT CLOSE THE DATACOLLECTOR WINDOW

XII. Data Viewing and Exporting – 1/1



XIII. Data Analysis — 1/1

NOTE: High Score can only be used on "High Score" computer outside in MSE 0051

1. If you plan on using *High Score*, transfer your files directly to your ENGR account's *Home (Z:) Drive* (stored in ENGR cloud) or use a flash drive

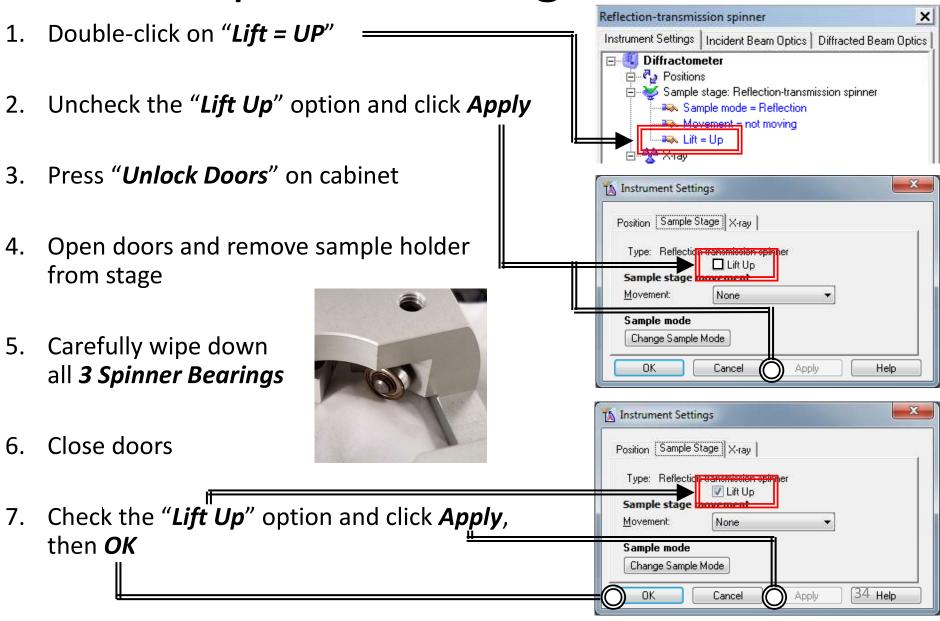


Your files can be accessed via VPN or on any networked computer if logged in with your ENGR account



- 2. Refer to "Introduction to PANalytical X'Pert HighScore Plus v3.0" guide by Scott A. Speakman available on desktop of "High Score" computer
- Guide is also available on MSE XRD website under Useful Documentation:
 - http://www.mse.ucr.edu/facilities_xrd.html

XIV. Sample Unloading – 1/1

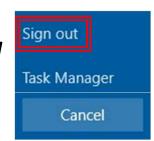


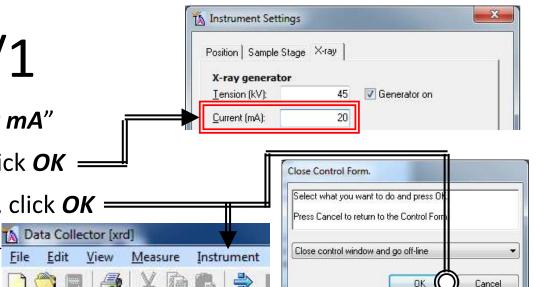


- Double-click on the "Current = 40 mA"
- 2. Change current back to **20 mA**, click **OK**
- 3. Select *Instrument -> Disconnect*, click *OK*
- 4. Select *File -> Exit* to log out ===
- 5. CLEAN THE SAMPLE HOLDER!
- 6. Return the sample holder pieces to its storage box
- 7. Replace slits with Standard Slit Configuration (1/2°, 1°, 8 mm) if different
- 8. Return any other used slits back to its storage box =
- 9. Brush up any sample that may have dropped into the cabinet
- 10. Turn *OFF* the lights to the cabinet (if ON) and *Close* doors (if open)
- 11. Record your **time-out** on the **sign-in sheet**, slits used, and any issues encountered like dirty sample holders or instrument errors
- 12. Click **Sign-out** of **ENGR Account** via **Windows**



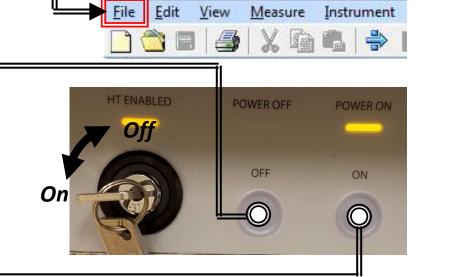
or via Ctrl+Alt+Del





XVI. Troubleshoot – 1/3

- 1. You may attempt to troubleshoot the XRD only if the following is observed:
 - An error message pops up showing:
 "Not safe, faulty switches on input 3 (left door)
 Error code: 3 64 0 9 3"
- 2. Select *Instrument -> Disconnect* if not already disconnected
- Select File -> Exit to close
 DataCollector and log out
- 6. Set the *Safety Key* to "Off" position
- 7. Press the "**Off**" button =
- 8. The instrument will perform a controlled power-down of the system
- 9. Set *Safety Key* to "*On*" position
- 10. Press and hold the "On" button =



Th Data Collector [xrd]

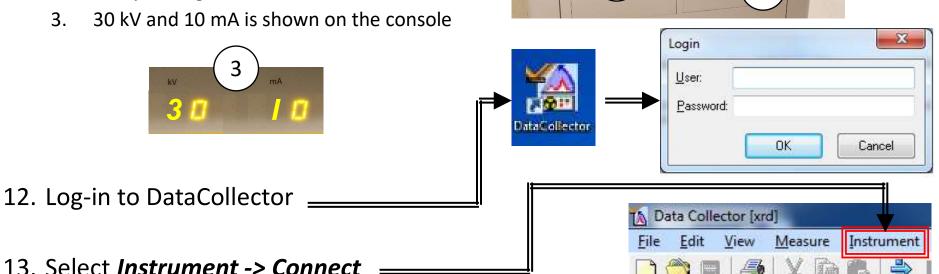
Data Collector [xrd]

Edit View

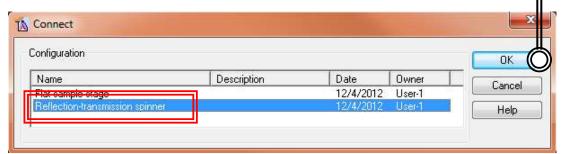
Measure Instrument

XVI. Troubleshoot -2/3

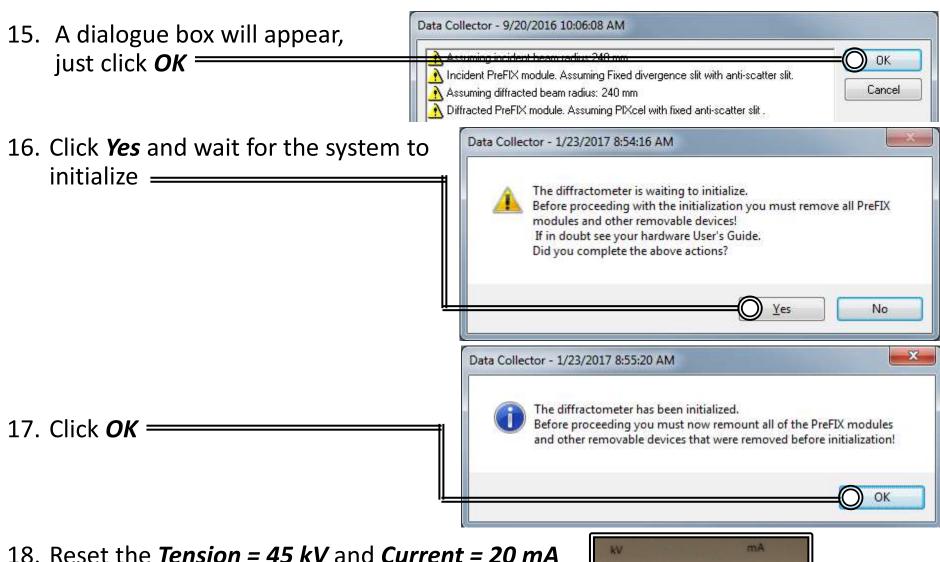
- 11. Wait until the following occurs:
 - 1. HT-enabled light turns on
 - 2. X-Rays On light turns on



14. Select *Reflection-Transmission Spinner* and click *OK*



XVI. Troubleshoot – 3/3



19. Continue with experiments



XVI. Troubleshoot – 1/1

- 1. For ALL issues, please contact the lab manager FIRST ASAP!
 - Call the lab manager at (951) 827-3378
 - E-mail the lab manager (Perry: pcheung@ucr.edu)
 - Stop by the lab manager's office at MSE 311